Categories: general confidential

# SPECIFICATIONS

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**Sunlord** 

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## Specifications for Multi-layer Chip Ferrite Bead

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## 【Version change history】

Rev.	Effective Date	Changed Contents	Change Reasons	Approved By
01	Apr.02, 2021	New release	New products	Guo Hai

#### [Caution]

All products listed in this specification are developed, designed and intended for use in general electronics equipment. The products are not designed or warranted to meet the requirements of the applications listed below, whose performance and/or quality require especially high reliability, or whose failure, malfunction or trouble might directly cause damage to society, person, or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below. Please contact us for more details if you intend to use our products in the following applications.

- 1. Aircraft equipment
- 2. Aerospace equipment
- 3. Undersea equipment
- 4. nuclear control equipment
- 5. military equipment
- 6. Power plant equipment
- 7. Medical equipment
- 8. Transportation equipment (automobiles, trains, ships,etc.)

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- 9. Traffic signal equipment
- 10. Disaster prevention / crime prevention equipment
- 11. Data-processing equipment
- 12. Applications of similar complexity or with reliability requirements comparable to the applications listed in the above

## 1. Scope

This specification applies to PZ0603U Series of multi-layer ferrite chip bead.

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## 2. Product Description and Identification (Part Number)

1) Description:

PZ0603U Series of ultra large current chip ferrite bead.

2) Product Identification (Part Number)

<u>PZ</u>	<u>0603</u>	<u>U</u>	<u>100</u>	<u>- 1R0</u>	<u>T</u>	<u>F</u>
1	2	3	4	(5)	6	7

① Туре		
PZ	For Large Current	

3	Material Code	
	U	

6	Packing		
Т	Tape Carrier Package		

7	HSF Products
На	zardous Substance Free Products

2	External Dimensions		(LXW)[mm]	
060	3 [0201]		0.6 X 0.3	

4 Nomi	nal Impedance
Example	Nominal Value
100	10Ω
121	120Ω

⑤ Rated Current		
1R0 1.00A		
R50	0.50A	

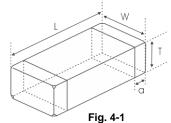
## 3. Electrical Characteristics

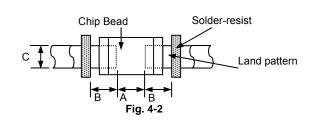
Please refer to **Appendix A** (Page 10).

- 1) Operating and storage temperature range (individual chip without packing): -55  $^{\circ}$ C ~ +125  $^{\circ}$ C.

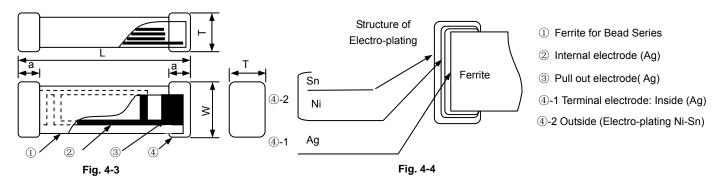
#### 4. Shape and Dimensions

- 1) Dimensions and recommended PCB pattern for reflow soldering: See Fig.4-1, Fig.4-2 and Table 4-1.
- 2) Structure: See Fig. 4-3 and Fig. 4-4.





		[Table 4-1]		Unit: mm [inch]			
Туре	L	W	Т	а	Α	В	С
0603 [0201]	0.6±0.05 [.024±0.002]	0.3±0.05 [.012±.002]	0.3±0.05 [.012±.002]	0.15±0.05 [.006±.002]	0.2~0.3	0.2~0.3	0.3~0.35



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## [Table 4-2]

Code	Part Name	Material Name
1	Ferrite Body	Ferrite Powder
2	Inner Coils	Silver Paste
3	Pull-out Electrode (Ag)	Silver Paste
<b>4</b> -1	Terminal Electrode: Inside Ag	Termination Silver Composition
<b>4</b> -2	Electro-Plating: Ni/Sn plating	Plating Chemicals

#### 5. Test and Measurement Procedures

#### 5.1 Test Conditions

- 5.1.1 Unless otherwise specified, the standard atmospheric conditions for measurement/test as:
  - a. Ambient Temperature:  $20\pm15^{\circ}$ C b. Relative Humidity:  $65\pm20\%$
  - c. Air Pressure: 86kPa to 106kPa
- 5.1.2 If any doubt on the results, measurements/tests should be made within the following limits:
  - a. Ambient Temperature: 20±2°C
    b. Relative Humidity: 65±5%
    c. Air Pressure: 86kPa to 106kPa

#### 5.2 Visual Examination

a. Inspection Equipment: 20× magnifier

#### 5.3 Electrical Test

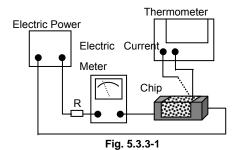
- 5.3.1 DC Resistance (DCR)
  - a. Refer to Appendix A.
  - b. Test equipment (Analyzer): High Accuracy Milliohmmeter-HP4338B or equivalent.

#### 5.3.2 Impedance (Z)

- a. Refer to Appendix A.
- b. Test equipment: High Accuracy RF Impedance /Material Analyzer-E4991A or equivalent. Test fixture: HP16197A for 0603, HP16192A for 1005/1608/2012/3216.
  - Test signal: -20dBm or 50mV
- c. Test frequency refers to Appendix A.

#### 5.3.3 Rated Current

- a. Refer to Appendix A.
- b. Test equipment (see **Fig.5.3.3-1**): Electric Power, Electric current meter, Thermometer.
- c. Measurement method (see Fig. 5.3.3-1):
  - 1. Set test current to be 0 mA.
  - 2. Measure initial temperature of chip surface.
  - 3. Gradually increase voltage and measure chip temperature for corresponding current.
- d. Definition of Rated Current (Ir): Ir is direct electric current as chip surface temperature rose just 20 ℃ against chip initial surface temperature (Ta) (see **Fig. 5.3.3-2**)



Temperature (°C)
+20
Ta
0
Rated current Ir (mA)

Fig. 5.3.3-2

## 5.4 Reliability Test

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Items	Requirements	Test Methods and Remarks  ① Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.1-1) using leadfree solder. Then apply a force in the direction of the arrow.  ② 2N force for 0603 series,  ③ Keep time: 10±1s.  ④ Speed: 1.0mm/s.  ① Solder the bead to the test jig (glass epoxy board shown in Fig. 5.4.2-1) Using a leadfree solder. Then apply a force in the direction shown Fig. 5.4.2-2.  ② Flexure: 2mm.  ③ Pressurizing Speed: 0.5mm/sec.  ④ Keep time: 30 sec.			
5.4.1 Terminal Strength  5.4.2 Resistance to Flexure	No removal or split of the termination or other defects shall occur.  Chip  Mounting Pad  Glass Epoxy Board  Fig.5.4.1-1  No visible mechanical damage.  Unit: mm [inch]  Type  a  b  c  0603[0201]  0.25  0.8  0.3				
5.4.3 Vibration	1 No visible mechanical damage. 2 Impedance change: within ±20%  Cu pad Solder mask  Glass Epoxy Board  Fig. 5.4.3-1	<ol> <li>Solder the bead to the testing jig (glass epoxy board shown in Fig. 5.4.3-1) using leadfree solder.</li> <li>The bead shall be subjected to a simple harmonic motion having total amplitude of 1.5 mm, the frequency being varied uniformly between the approximate limits of 10 and 55 Hz.</li> <li>The frequency range from 10 to 55 Hz and return to 10 Hz sha be traversed in approximately 1 minute. This motion shall be applied for a period of 2 hours in each 3mutually perpendicular directions (total of 6 hours).</li> </ol>			
5.4.4 Dropping	<ol> <li>No visible mechanical damage.</li> <li>Impedance change: within ±20%.</li> </ol>	Drop chip bead 10 times on a concrete floor from a height of 100 cm.			
5.4.5 Temperature	Impedance change should be within ±20% of initial value measuring at 20°C.	Temperature range: -55°C ~ 125°C. Reference temperature: +20°C.			
5.4.6 Solderability	No visible mechanical damage.     Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others	<ol> <li>Solder temperture:240±2℃</li> <li>Duration: 3 sec.</li> <li>Solder: Sn/3.0Ag/0.5Cu.</li> <li>Flux: 25% Resin and 75% ethanol in weight.</li> </ol>			
5.4.7 Resistance to Soldering Heat	<ol> <li>No visible mechanical damage.</li> <li>Wetting shall exceed 75% coverage for 0603 series; exceed 95% for others</li> <li>Impedance change: within ±20%.</li> </ol>	<ol> <li>Solder temperature :260±3°C</li> <li>Duration: 5 sec.</li> <li>Solder: Sn/3.0Ag/0.5Cu.</li> <li>Flux: 25% Resin and 75% ethanol in weight.</li> <li>The chip shall be stabilized at normal condition for 1~2 hours before measuring.</li> </ol>			

5.4.8	No mechanical damage.	① Temperature, Time: (See Fig.5.4.8-1)
Thermal Shock	② Impedance change: Within ±20%.	-55°C for 30±3 min→125°C for 30±3min.
		② Transforming interval: Max. 20 sec.
	30 min. 30 min.	③ Tested cycle: 100 cycles.
	125°C	4 The chip shall be stabilized at normal condition for 1~2 hours
	Ambient /	before measuring.
	Temperature 30 min.	
	-55℃ →	
	Fig. 5.4.8-1 <sup>20sec. (max.)</sup>	
5.4.9	① No mechanical damage.	① Temperature: -55±2°C
Resistance to	② Impedance change: within ±20%.	② Duration: 1000 <sup>+24</sup> hours.
Low		③ The chip shall be stabilized at normal condition for 1~2 hours
Temperature		before measuring.
5.4.10	① No mechanical damage.	① Temperature: 125±2°C
Resistance to	② Impedance change: within ±20%.	② Duration: 1000 <sup>+24</sup> hours.
High		③ The chip shall be stabilized at normal condition for 1~2 hours
Temperature		before measuring.
5.4.11	① No mechanical damage.	① Temperature: 60±2°C
Damp Heat	② Impedance change: Within ±20%.	② Humidity: 90% to 95% RH.
(Steady States)		③ Duration: 1000 <sup>+24</sup> hours.
		4 The chip shall be stabilized at normal condition for 1~2 hours
		before measuring.
5.4.12	No visible mechanical damage.	① Temperature: 60±2℃
Loading Under	② Impedance change: within ±20%.	② Humidity: 90% to 95% RH.
Damp Heat		③ Duration: 1000 <sup>+24</sup> hours.
		Applied current: Rated current.
		5 The chip shall be stabilized at normal condition for 1~2 hours
		before measuring.
5.4.13	No visible mechanical damage.	① Temperature: 125±2℃
Loading at High	② Impedance change: within ±20%.	② Duration: 1000 <sup>+24</sup> hours.
Temperature	•	3 Applied current: Rated current.
(Life Test)		4 The chip shall be stabilized at normal condition for 1~2 hours
·		before measuring.

## Packaging, Storage

## 6.1 Packaging

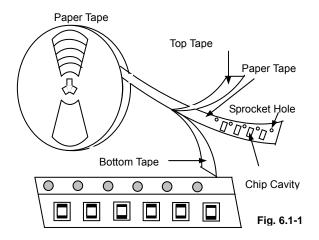
Tape Carrier Packaging:

Packaging code: T

- Tape carrier packaging are specified in attached figure Fig.6.1-1~3
- Tape carrier packaging quantity please see the following table:

Туре	0603[0201]		
T(mm)	0.3±0.15		
Tape	Paper Tape		
Quantity	15K		

## (1) Taping Drawings (Unit: mm)



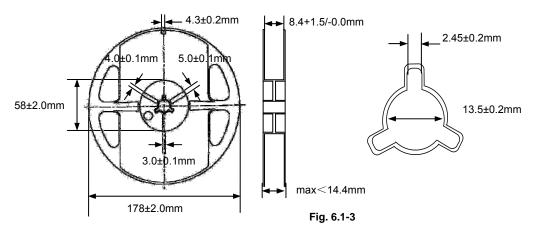
## 

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Paper Tape

Туре	Α	В	Р	T max
0603[0201]	0.40±0.1	0.70±0.1	2.0±0.1	0.55

#### 3) Reel Dimensions (Unit: mm)



#### 6.2 Storage

- a. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to high humidity. Package must be stored at 40°C or less and 70% RH or less.
- b. The solderability of the external electrode may be deteriorated if packages are stored where they are exposed to dust of harmful gas (e.g. HCI, sulfurous gas of  $H_2S$ ).
- c. Packaging material may be deformed if package are stored where they are exposed to heat of direct sunlight.
- d. Solderability specified in **Clause 5.4.6** shall be guaranteed for 6 months from the date of delivery on condition that they are stored at the environment specified in **Clause 3**. For those parts, which passed more than 6 months shall be checked solder-ability before use.

#### 7. Recommended Soldering Technologies

## 7.1 Re-flowing Profile:

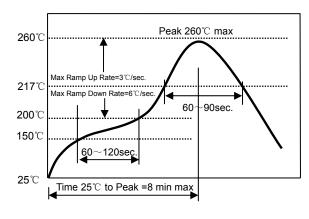
- △ Preheat condition: 150 ~200 °C/60~120sec.
- △ Allowed time above 217°C: 60~90sec.
- △ Max temp: 260°C

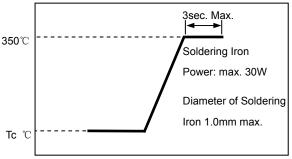
[Note: The reflow profile in the above table is only for qualification and is not meant to specify board assembly profiles. Actual board assembly profiles must be based on the customer's specific board design, solder paste and process, and should not exceed the parameters as the Reflow profile shows.]

#### 7.2 Iron Soldering Profile.

- △ Iron soldering power: Max.30W
- $\triangle$  Pre-heating: 150  $^{\circ}$ C / 60sec.
- △ Soldering Tip temperature: 350 °C Max.
- △ Soldering time: 3sec Max.
- △ Solder paste: Sn/3.0Ag/0.5Cu
- $\triangle$  Max.1 times for iron soldering

[Note: Take care not to apply the tip of the soldering iron to the terminal electrodes.]





## **Appendix A: Electrical Characteristics**

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## I. PZ0603U Series of Beads

Part Number	Impedance (Ω)	Z Test Freq. (MHz)	DCR (Ω) Max.	Ir (mA) Max.	Thickness (mm) [inch]
PZ0603U100-1R0TF	10±5	100	0.05	1000	
PZ0603U800-R50TF	80±25%	100	0.18	500	
PZ0603U121-R45TF	120±25%	100	0.23	450	0.3±0.05
PZ0603U241-R35TF	240±25%	100	0.38	350	[.012±.002]
PZ0603U601-R25TF	600±25%	100	0.85	250	
PZ0603U102-R20TF	1000±25%	100	1.25	200	

## **Impedance Frequency Characteristics**

